

# Special Topics on Basic EECS I Design Technology Co-Optimization

## Lecture 17

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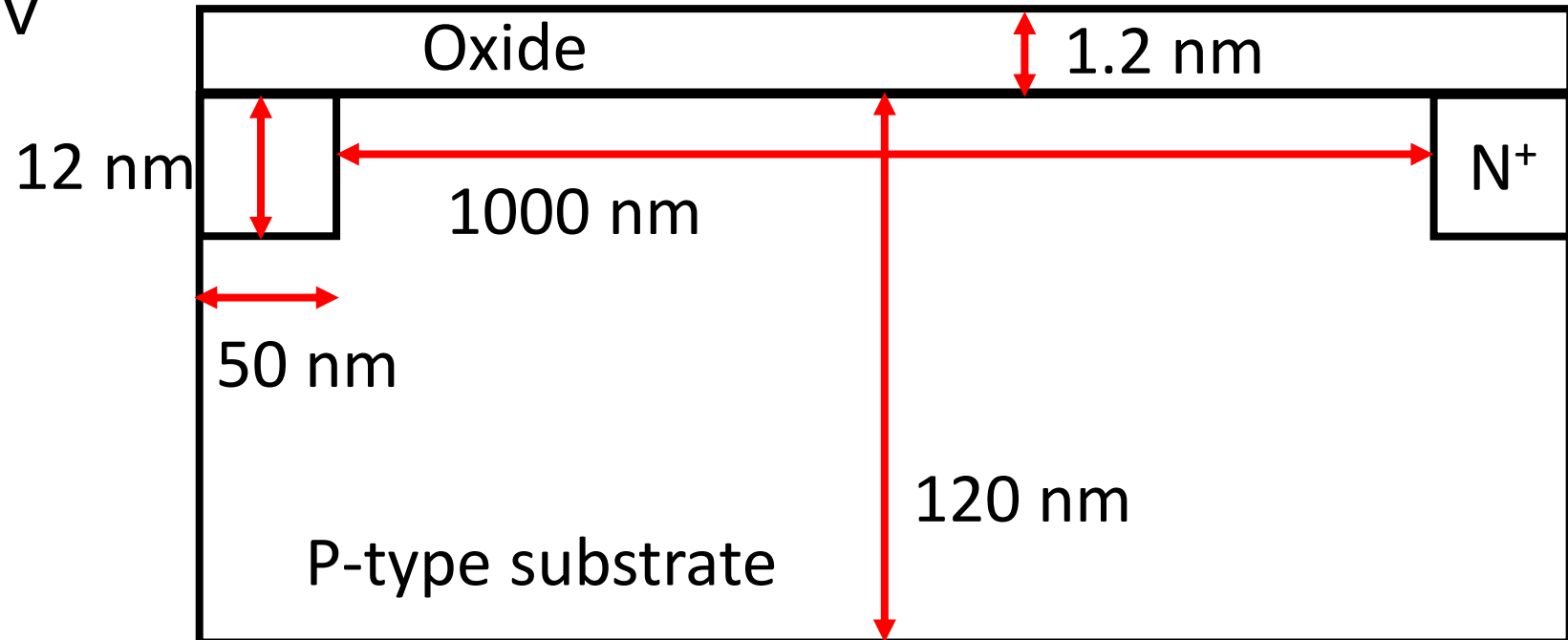
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# L17

# Simulation of a long-channel MOSFET

- Effective oxide thickness of 1.2 nm
  - Gate workfunction of 4.3 eV
  - Substrate doping of  $1.5 \times 10^{18} \text{ cm}^{-3}$
  - $V_{DD}$  of 1.2 V

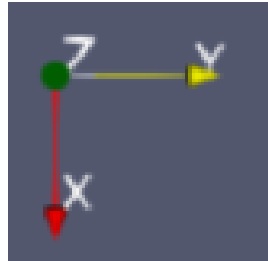


# Structure generation

- Spacing along the vertical direction: 1.2 nm
  - Spacing along the lateral direction: 5 nm
  - How many points?  $102 \times 221 = 22542$
  - Too many points for such a simple structure...
- Source/drain doping profile
  - Gaussian profile is usually used.
  - In this example, abrupt junctions are assumed.

# Mapmaker

- Input file
  - $x$ : Depth
  - $y$ : Channel
  - $z$ : Width



```
thing (type="mapmaker",name="structure") {
  mapmaker (type="3d",cgns="long.cgns") {
    cuboid (x0=-1.2nm,y0=-550nm,x1=120nm,y1=550nm,z0=0.0,z1=1.0um,nx=102,ny=221,nz=2)
    region (name="semiconductor",material="silicon",ix0=1,ix1=101,iy0=0,iy1=220,iz0=0,iz1=1)
    region (name="insulator",material="oxide",ix0=0,ix1=1,iy0=0,iy1=220,iz0=0,iz1=1)
    doping (region="semiconductor",ix0=1,ix1=101,iy0=0,iy1=220,iz0=0,iz1=1,density=-1.5e18/cm3)
    doping (region="semiconductor",ix0=1,ix1=11,iy0=0,iy1=10,iz0=0,iz1=1,density=2e20/cm3)
    doping (region="semiconductor",ix0=1,ix1=11,iy0=210,iy1=220,iz0=0,iz1=1,density=2e20/cm3)
    contact (name="source",ix0=1,ix1=6,iy0=0,iy1=0,iz0=0,iz1=1)
    contact (name="gate",ix0=0,ix1=0,iy0=10,iy1=210,iz0=0,iz1=1)
    contact (name="drain",ix0=1,ix1=6,iy0=220,iy1=220,iz0=0,iz1=1)
    contact (name="body",ix0=101,ix1=101,iy0=0,iy1=220,iz0=0,iz1=1)
  }
}
```

# Long-channel device structure

- It is not very realistic.
  - Abrupt source/drain doping
  - Constant substrate doping
  - Spacer
  - Source/drain contact



# Loading the sturcture

- In a MOSFET, we have a gate contact.
  - The workfunction must be specified.
  - Do not forget to specify the bandgap narrowing model.

```
thing (type="device",name="mosfet") {  
  device (type="3d",areafactor=1.0) {  
    load (cgns="long.cgns",dbpath="/  
    electrode (name="gate",workfunction=4.3)  
  }  
}  
  
property (thing="mosfet",model="effectiveintrinsicdensity",nobandgapnarrowing)
```

Here goes your dbpath.

# Building a circuit

- We need (at least) two voltage sources.
  - Prepare them ( $v_g$  and  $v_d$  in this example) and build a circuit.

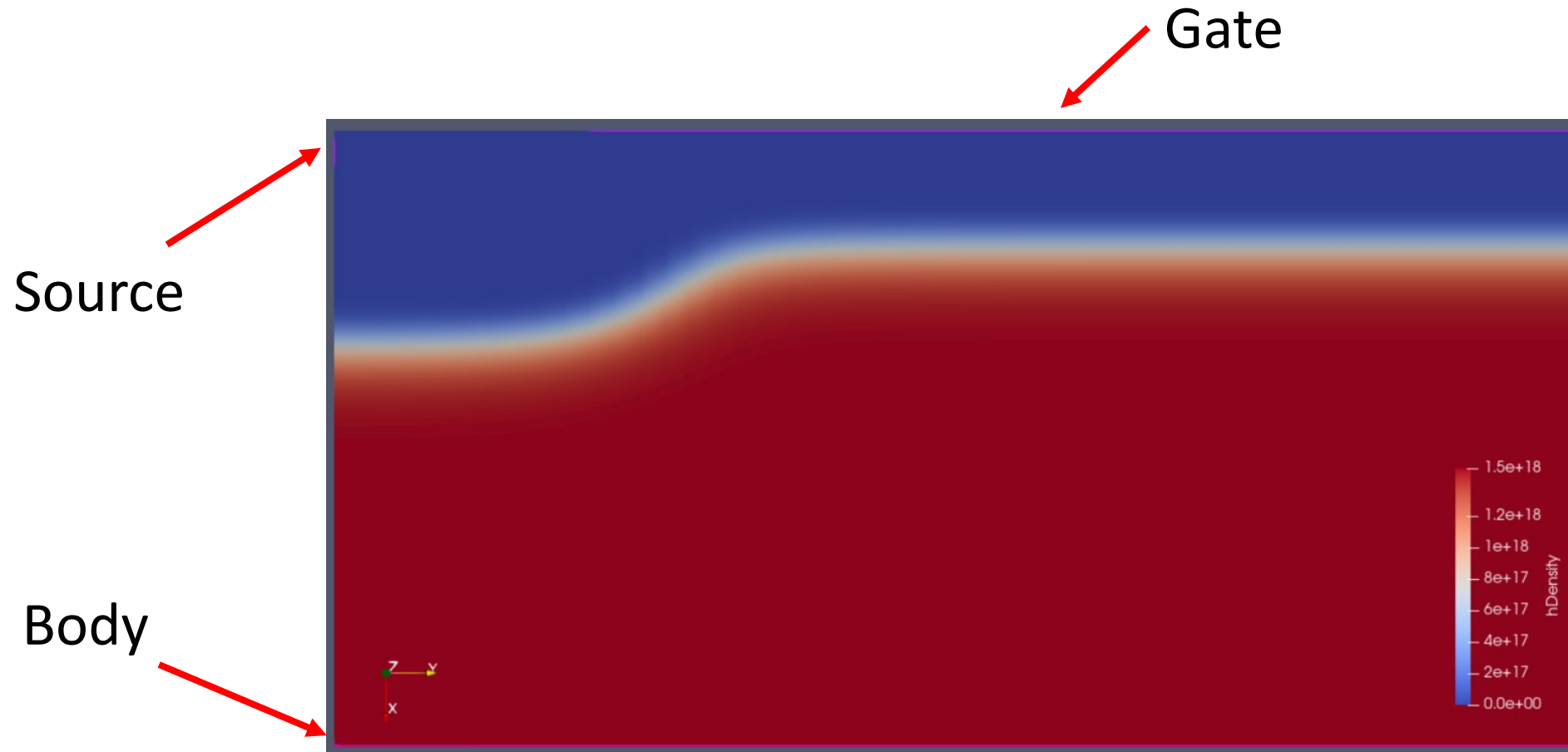
```
thing (type="lumped",name="vg") {  
    lumped (type="v",value=0.0)  
}  
  
thing (type="lumped",name="vd") {  
    lumped (type="v",value=0.0)  
}  
  
thing (type="circuit",name="circuit") {  
    circuit {  
        node (thing="gnd",name="GND")  
        node (thing="mosfet", contact="source",name="GND")  
        node (thing="mosfet", contact="gate", name="IN")  
        node (thing="mosfet", contact="drain", name="OUT")  
        node (thing="mosfet", contact="body", name="GND")  
        node (thing="vg", contact="0", name="GND")  
        node (thing="vg", contact="1", name="IN")  
        node (thing="vd", contact="0", name="GND")  
        node (thing="vd", contact="1", name="OUT")  
    }  
}
```



# Equilibrium

```
law (name="eqlaw") {  
    equation (type="poisson",thing="mosfet")  
}  
  
solve (law="eqlaw",initialstep=1.0,plot,plotprefix="long_eq",cgns)
```

- Depletion of holes



# Setting a law and a book

- Drift-diffusion simulation and IV curves
  - There are two voltage sources. Therefore, we need to specify the “virlc” equation twice.

```
law (name="dclaw", iteration=12) {  
    equation (type="poisson", thing="mosfet")  
    equation (type="econtinuity", thing="mosfet")  
    equation (type="hcontinuity", thing="mosfet")  
    equation (type="contact", thing="mosfet")  
    equation (type="virlc", thing="vg")  
    equation (type="virlc", thing="vd")  
    equation (type="kirchhoff", thing="circuit")  
}
```

```
book (name="input_iv", csv="input_iv.csv") {  
    event (thing="mosfet", contact="gate")  
    event (thing="mosfet", contact="drain")  
}
```

# Bias ramping

- Usually, we consider two drain voltages.
  - A voltage close to zero,  $V_D \approx 0$  V & a voltage equal to  $V_{DD}$
  - In the following example, we take 0.05 V.

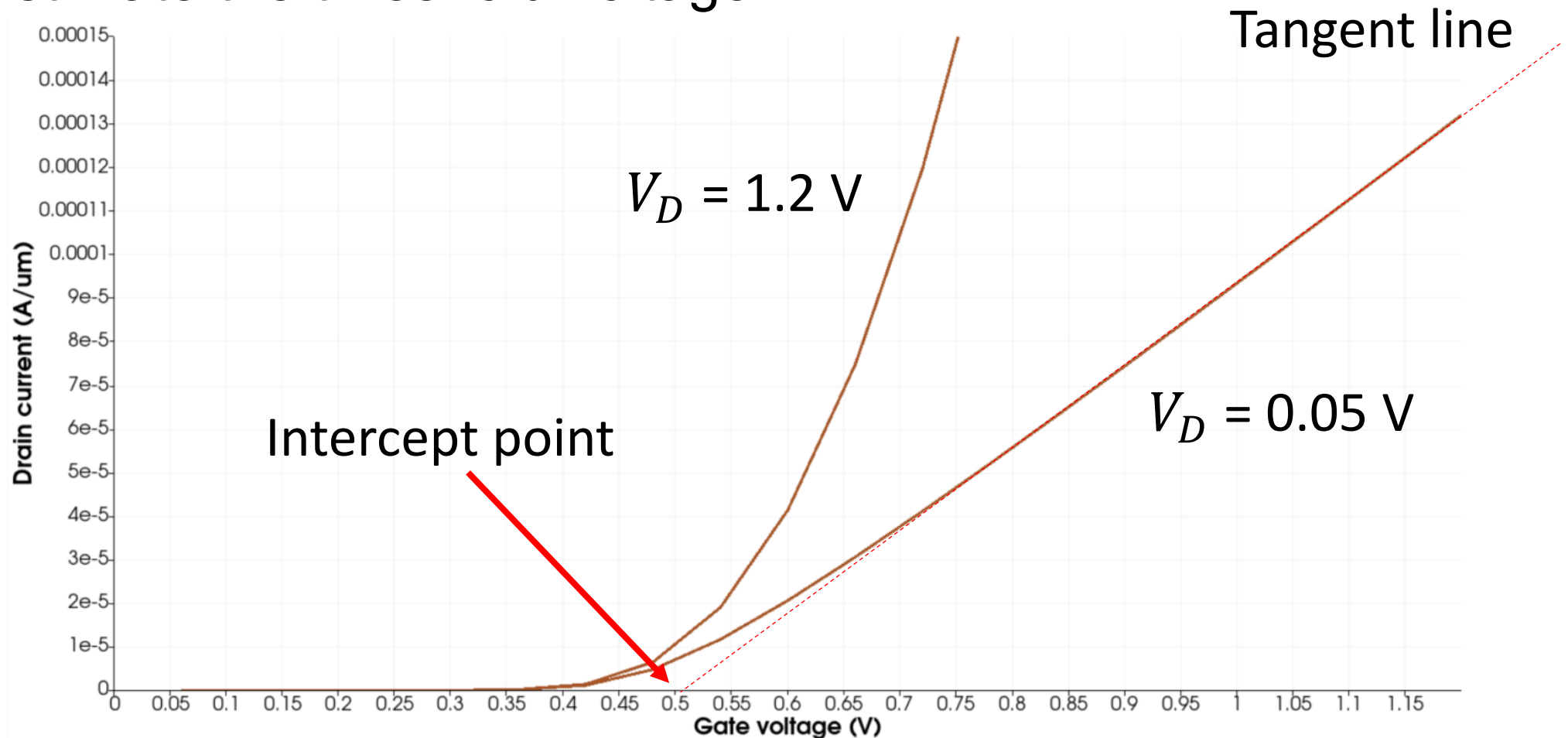
```
solve (law="dclaw",initialstep=1.0) {  
    goal (thing="vd", quantity="voltage", value=0.05)  
}
```

- After running this `solve` statement, we have a solution at  $V_G = 0$  V and  $V_D = 0.05$  V.
- Then,

```
solve (law="dclaw",initialstep=0.01,maxstep=0.01,minstep=0.01,plot,plotprefix="long_dc",cgns,book="input_iv") {  
    goal (thing="vg", quantity="voltage", value=1.2)  
}
```

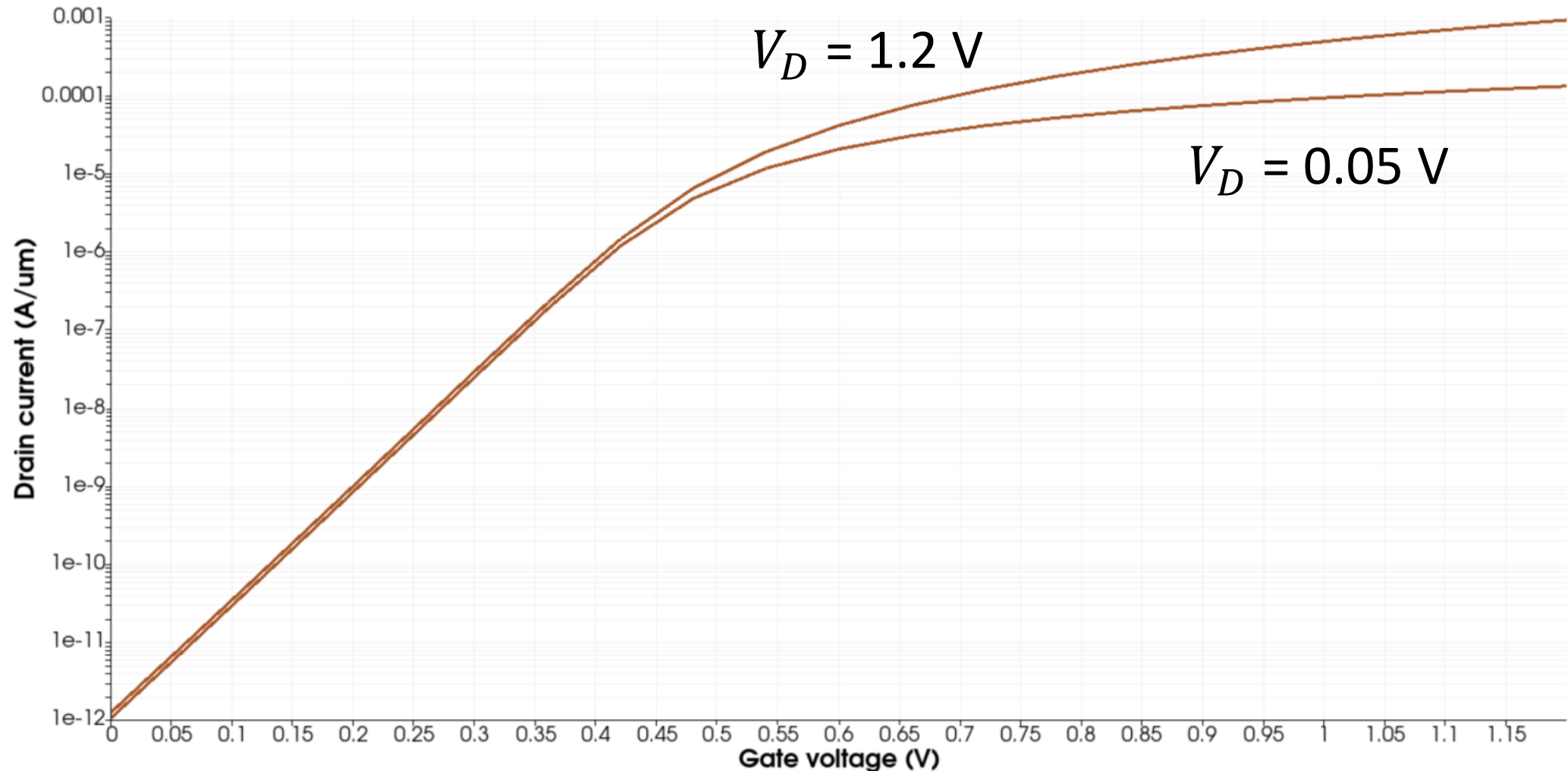
# Ramping the gate voltage up

- Results WITHOUT any physical model, from 0 V to 1.2 V
  - Estimate the threshold voltage.



# Semi-logarithmic graph

- Estimate the subthreshold slope, the DIBL,  $I_{ON}$ , and  $I_{OFF}$ .



# Thank you!